



FQD24N08 / FQU24N08

80V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

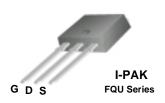
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as automotive, high efficiency switching for DC/DC converters, and DC motor control.

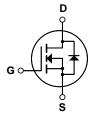
Features

- 19.6A, 80V, $R_{DS(on)} = 0.06\Omega$ @ $V_{GS} = 10 V$
- Low gate charge (typical 19 nC)
- Low Crss (typical 50 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- RoHS Compliant









Absolute Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter		FQD24N08 / FQU24N08	Units
V_{DSS}	Drain-Source Voltage		80	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		19.6	Α
			12.4	А
I _{DM}	Drain Current - Pulsed	(Note 1)	78.4	Α
V _{GSS}	Gate-Source Voltage		± 25	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	230	mJ
I _{AR}	Avalanche Current	(Note 1)	19.6	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		6.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
_	Power Dissipation (T _C = 25°C)		50	W
	- Derate above 25°C		0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	P _{0JC} Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA				V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.08		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μА
		V _{DS} = 64 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	racteristics		•			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 9.8 A		0.048	0.06	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 30 V, I _D = 9.8 A (Note 4)		11.5		S
Dynamic Characteristics C_{iss} Input Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$			580	750	pF	
C _{oss}	Output Capacitance	f = 1.0 MHz		210	270	pF
C _{rss}	Reverse Transfer Capacitance	1		50	65	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	o On Dolov Timo		10	30	ns
t _r	Turn-On Rise Time	$V_{DD} = 40 \text{ V}, I_{D} = 24 \text{ A},$		105	220	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25 \Omega$		30	70	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		35	80	ns
Q _g	Total Gate Charge	V _{DS} = 64 V, I _D = 24 A,		19	25	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		4.2		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		9.6		nC
			•			
Drain-S	Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current				19.6	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				78.4	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 19.6 A			1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 10.0 \text{ A}$		63		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		130		nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 0.82mH, I_{AS} = 19.6A, V_{DD} = 25V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} \leq 24A, di/dt \leq 300A/ μ s, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300 μ s, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

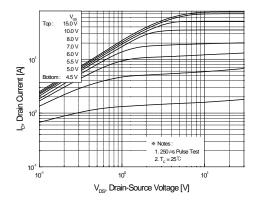


Figure 1. On-Region Characteristics

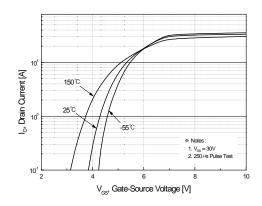


Figure 2. Transfer Characteristics

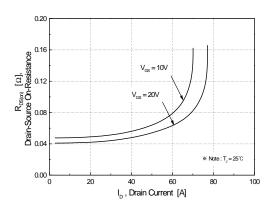


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

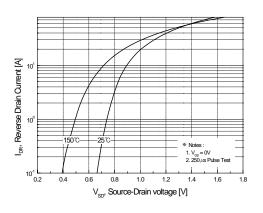


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

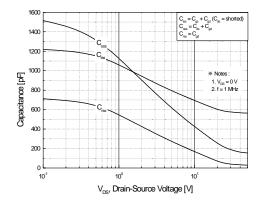


Figure 5. Capacitance Characteristics

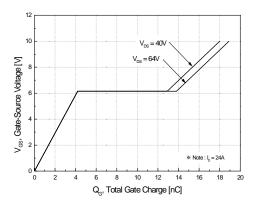
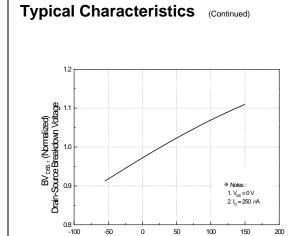


Figure 6. Gate Charge Characteristics



-50

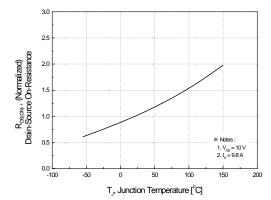
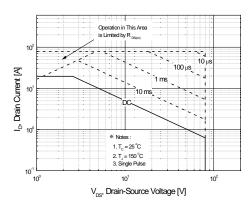


Figure 7. Breakdown Voltage Variation vs. Temperature

 $T_{_{\!J}}$, Junction Temperature [°C]

150

Figure 8. On-Resistance Variation vs. Temperature



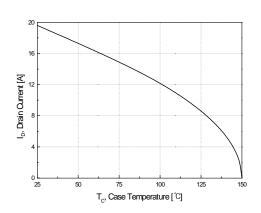


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

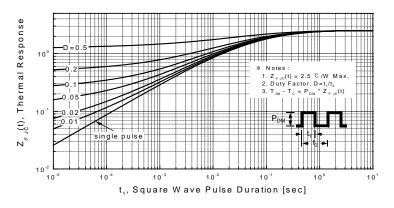
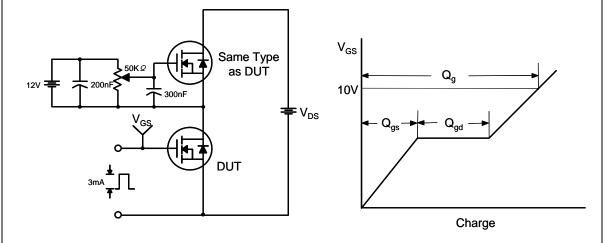
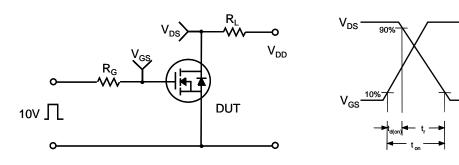


Figure 11. Transient Thermal Response Curve

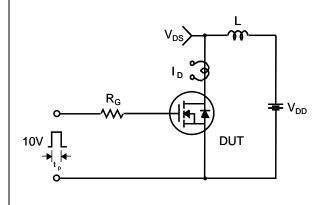
Gate Charge Test Circuit & Waveform

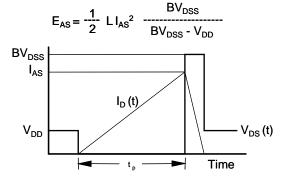


Resistive Switching Test Circuit & Waveforms

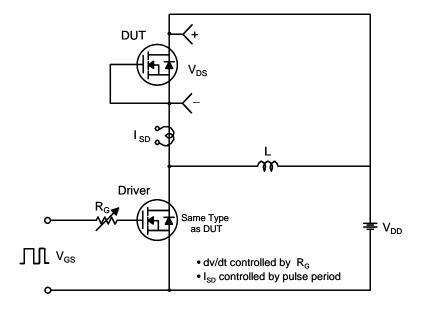


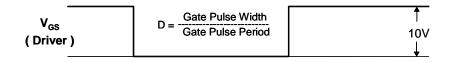
Unclamped Inductive Switching Test Circuit & Waveforms

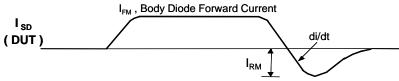




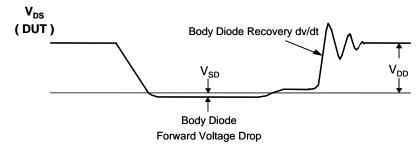
Peak Diode Recovery dv/dt Test Circuit & Waveforms







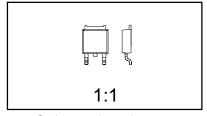
Body Diode Reverse Current



Package Dimensions

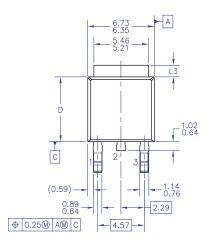
TO-252 (DPAK) (FS PKG Code 36)

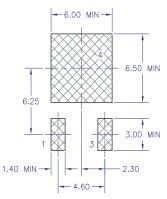




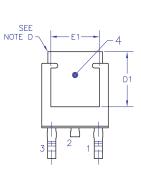
Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

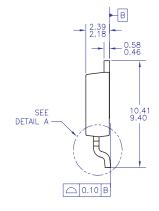
Part Weight per unit (gram): 0.33

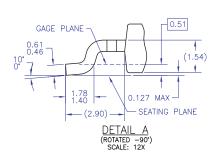




LAND PATTERN RECOMMENDATION







- NOTES: UNLESS OTHERWISE SPECIFIED

 A) ALL DIMENSIONS ARE IN MILLIMETERS.

 B) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

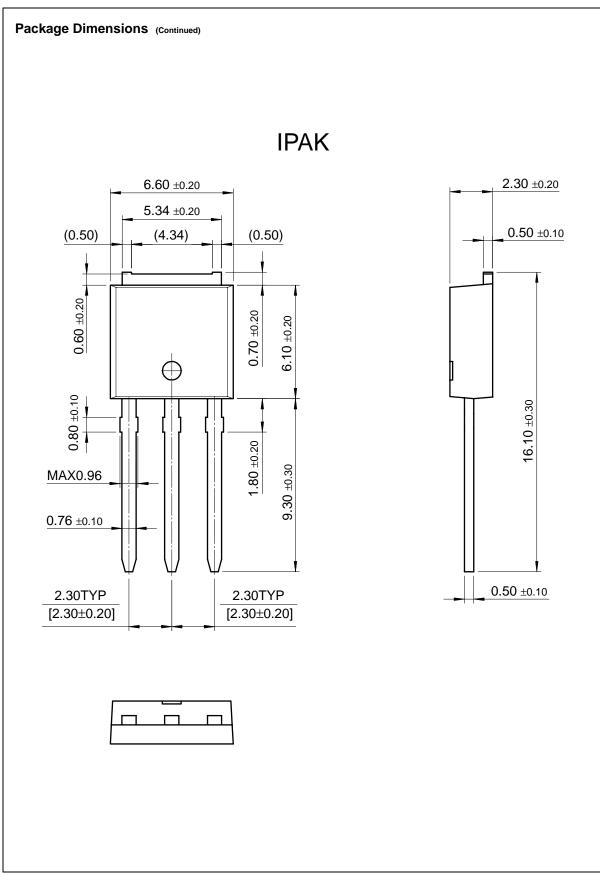
 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

 D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.

 F) DIMENSIONS 13 D F1&P1 TABLE.

 - DIMENSIONS L3,D,E1&D1 TABLE:

	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN







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